TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (Ultra-High-Speed U-MOSIII)

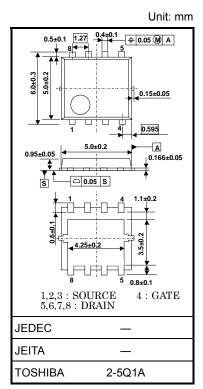
TPCA8003-H

High Efficiency DC/DC Converter Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to a small and thin package
- High speed switching
- Small gate charge: QSW = 8.4 nC (typ.)
- Low drain-source ON-resistance: RDS (ON) = 5.1 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 60S$ (typ.)
- Low leakage current: $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$
- Enhancement mode: $V_{th} = 1.1 \text{ to } 2.3 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA)}$

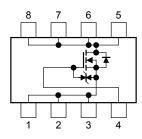
Absolute Maximum Ratings (Ta = 25°C)

Characte	ristic	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	30	V	
Drain-gate voltage (R	$G_{\rm GS} = 20 \text{ k}\Omega$	V_{DGR}	30	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	35	Α	
Diain current	Pulsed (Note 1)	I _{DP}	105	Α	
Drain power dissipation	on (Tc=25°C)	PD	45	W	
Drain power dissipation	on (t = 10 s) (Note 2a)	P_{D}	2.8	W	
Drain power dissipation	on (t = 10 s) (Note 2b)	PD	1.6	W	
Single-pulse avalanch	ne energy (Note 3)	E _{AS}	159	mJ	
Avalanche current		I _{AR}	35	Α	
Repetitive avalanche	energy c=25°C) (Note 4)	E _{AR}	4.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	



Weight: 0.069 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

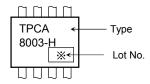
This transistor is an electrostatic-sensitive device. Handle with care.



Thermal Characteristics

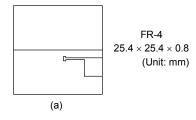
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25°C)	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	44.6	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	78.1	°C/W

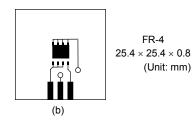
Marking (Note 5)



- Note 1: The channel temperature should not exceed 150°C during use.
- Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)





- Note 3: $V_{DD}=24~V, T_{ch}=25^{\circ}C$ (initial), $L=0.1~mH, R_{G}=25~\Omega, I_{AR}=35~A$
- Note 4: Repetitive rating: pulse width limited by max. channel temperature
- Note 5: * Weekly code: (Three digits)

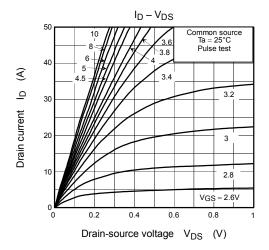


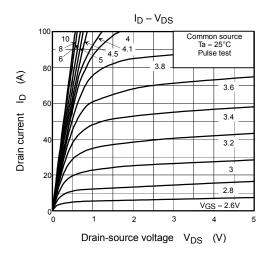
Electrical Characteristics (Ta = 25°C)

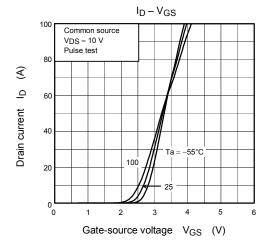
Ch	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА	
Drain cutoff curre	nt	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	_	_	10	μА	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	30	_	_	V	
Diain-source bre	akdowii voltage	V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15 — — 1.1 — 2.3		V		
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	1.1	_	2.3	V	
Drain aguras ON	rosistanos	D= 0 (01)	V _{GS} = 4.5 V, I _D = 18 A	_	7.3	9.5		
Drain-source ON-resistance		R _{DS} (ON)	V _{GS} = 10 V, I _D = 18 A		5.1	6.6	mΩ	
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, I_D = 18 \text{ A}$	30	60	_	S	
Input capacitance	•	C _{iss}			1465	_		
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		175	_	pF	
Output capacitance		Coss			610	_		
Switching time	Rise time	t _r	Ves 10 V	_	4	_	- ns	
	Turn-on time	t _{on}		_	11	_		
	Fall time	t _f		_	10	_		
	Turn-off time	t _{off}	$V_{DD} \simeq 15 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \mu\text{s}$	_	36	_		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 35 \text{ A}$		25	_		
			$V_{DD} \simeq 24 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 35 \text{ A}$	_	13	_		
Gate-source charge 1		Q _{gs1}	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 35 \text{ A}$	_	5.8	_	nC	
Gate-drain ("Miller") charge		Q _{gd}			5.1	_		
Gate switch charge		Q _{SW}		_	8.4	_		

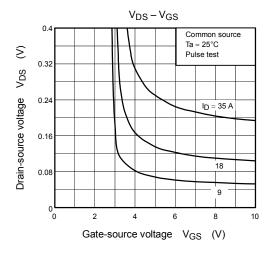
Source-Drain Ratings and Characteristics (Ta = 25°C)

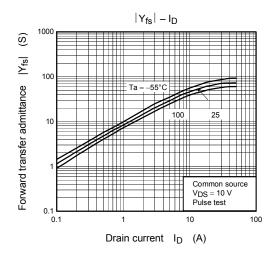
Character	istic		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse	(Note 1)	I _{DRP}	_	_	_	105	Α
Forward voltage (diode)			V _{DSF}	I _{DR} = 35 A, V _{GS} = 0 V	_	_	-1.2	V

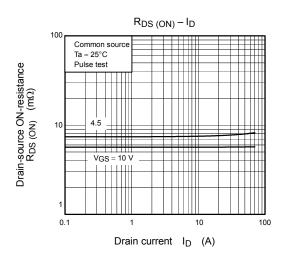




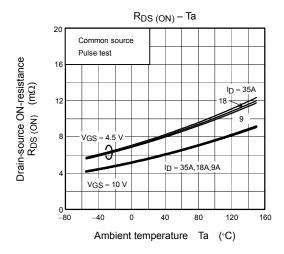


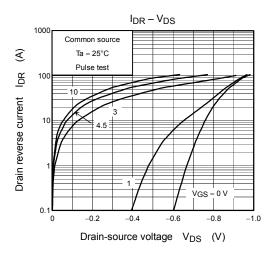


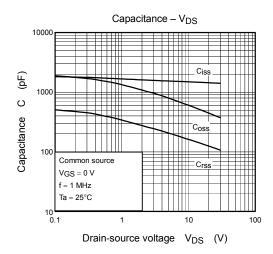


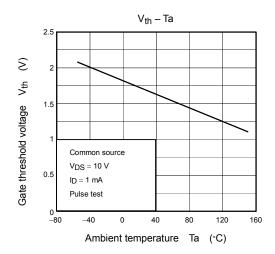


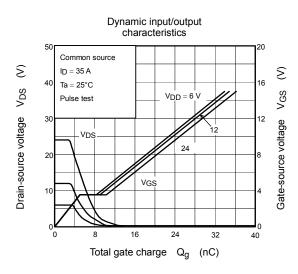
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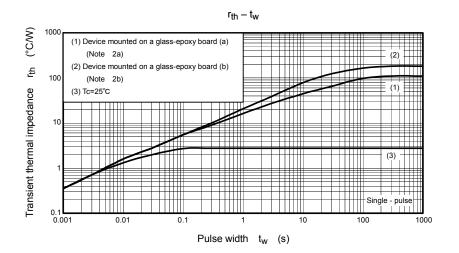


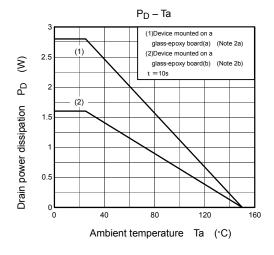


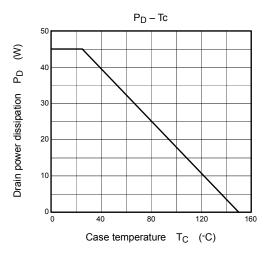


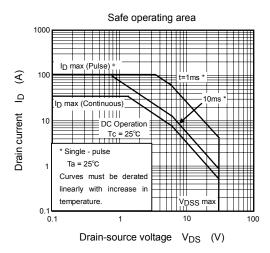


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Handbook" etc. 021023_A

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